

80V N-Channel Power SpeedFET

General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. It is suitable for automotive application.

Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

Application

- BLDC Motor driver
- DC-DC
- Load Switch

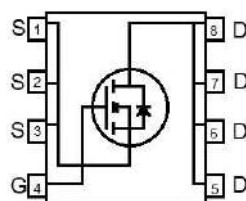
Ordering Information:

Part NO.	KPRZMS019N08H-V
Marking	ZMS019N08H

Absolute Maximum Ratings $(T_C=25^{\circ}\text{C})$

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		80	V
Gate-Source Voltage ^①	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^{\circ}\text{C}$	176	A
	I_D	$T_C=75^{\circ}\text{C}$	144	A
	I_D	$T_C=100^{\circ}\text{C}$	120	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^{\circ}\text{C}$;	704	A
Total Power Dissipation	P_D	$T_C=25^{\circ}\text{C}$	150	W
Total Power Dissipation	P_D	$T_A=25^{\circ}\text{C}$	3.3	W
Operating Junction Temperature	T_J		-55 to +175	$^{\circ}\text{C}$
Storage Temperature	T_{STG}		-55 to +175	$^{\circ}\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	423	mJ
		$L=0.5\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	698	mJ
ESD Level (HBM)	CLASS 2			

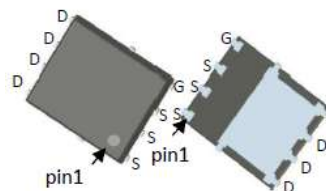
Product Summary



$$V_{DS} = 80\text{V}$$

$$R_{DS(ON)} = 1.9\text{m}\Omega$$

$$I_D = 176\text{A}$$



DFN5*6



• **Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}		-	1.0	°C/W
Thermal resistance, junction-ambient	$R_{thJA}^{②}$		-	45	°C/W
Soldering temperature	T_{sold}		-	260	°C

• **Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	80			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	2.0	2.7	4.0	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS} = 0V, V_{DS} = 80V$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 30A$		1.9	2.3	m Ω
Forward Transconductance	g_{FS}	$V_{DS} = 5V, I_{SD} = 10A$		34		S
Diode Forward Voltage	V_{FSD}	$V_{GS} = 0V, I_{SD} = 30A$			1.3	V

• **Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 40V, f = 1MHz,$	-	5431	-	pF
Output capacitance	C_{oss}		-	1532	-	
Reverse transfer capacitance	C_{rss}		-	49	-	
Gate Resistance	R_g	$f = 1MHz$	-	1.5		Ω
Total gate charge	Q_g	$V_{DD} = 15V,$ $I_D = 30A,$ $V_{GS} = 10V$	-	91	-	nC
Gate - Source charge	Q_{gs}		-	23	-	
Gate - Drain charge	Q_{gd}		-	24	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS} = 10V, V_{DS} = 15V,$ $R_G = 3.3\Omega, I_D = 20A$	-	17	-	ns
Turn-ON Rise time	t_r		-	12	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	30	-	ns
Turn-Off Fall time	t_f		-	21	-	ns
Reverse Recovery Time	t_{RR}	$V_{DD} = 20V, dI_S/dt = 100A/\mu s, I_S = 50A$	-	87	-	ns
Reverse Recovery Charge	Q_{RR}		-	142	-	nC

Fig.1 Gate-Charge Characteristics

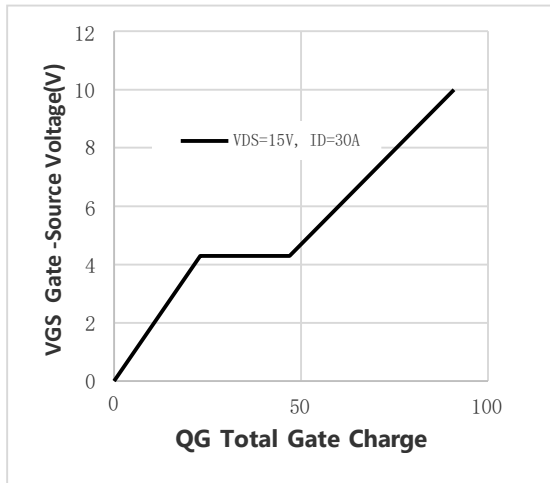


Fig.2 Capacitance Characteristics

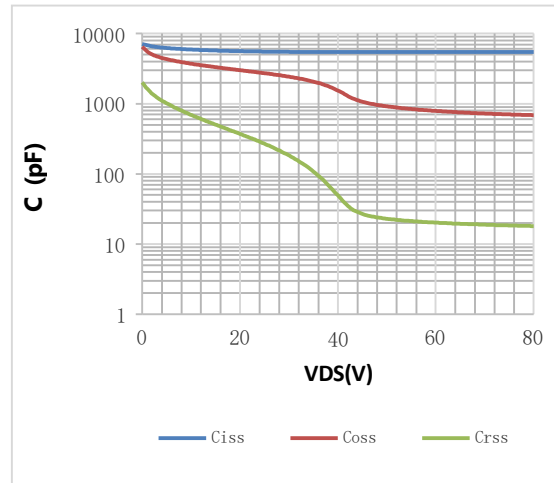


Fig.3 Power Dissipation

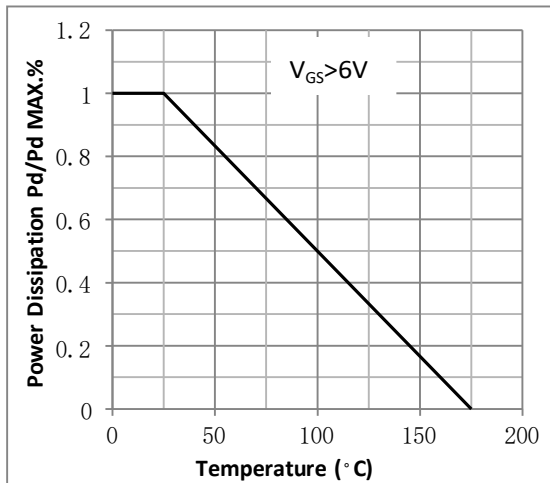


Fig.4 Typical output Characteristics

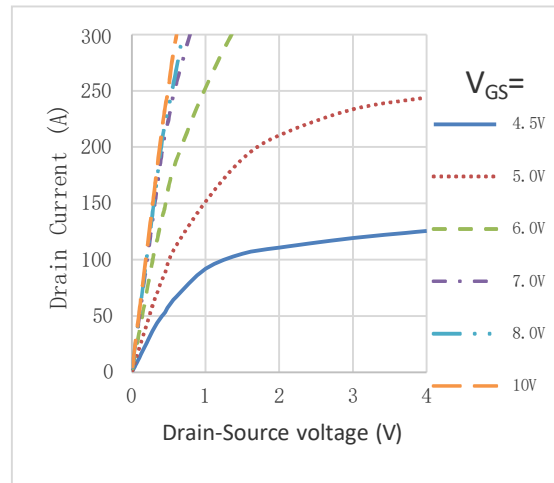


Fig.5 Threshold Voltage V.S Junction Temperature

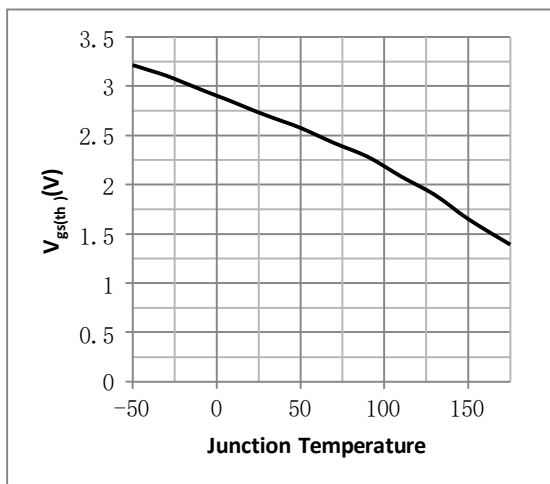


Fig.6 Resistance V.S Drain Current

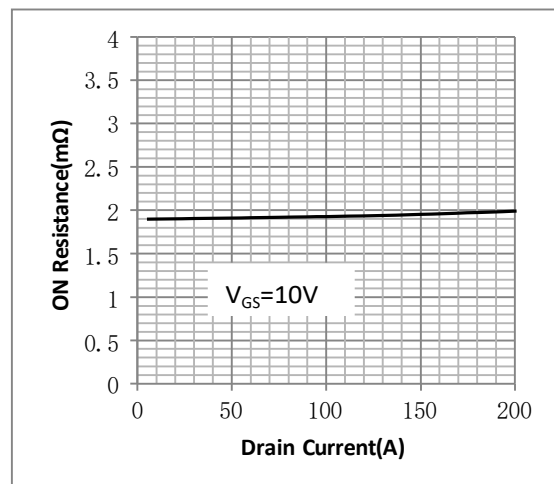


Fig.7 On-Resistance VS Gate Source Voltage

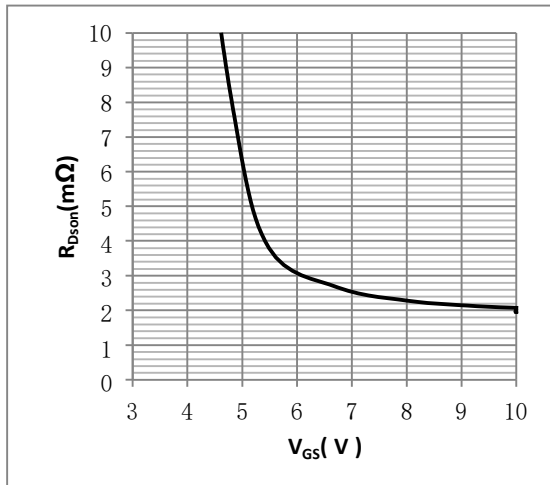


Fig.8 On-Resistance V.S Junction Temperature

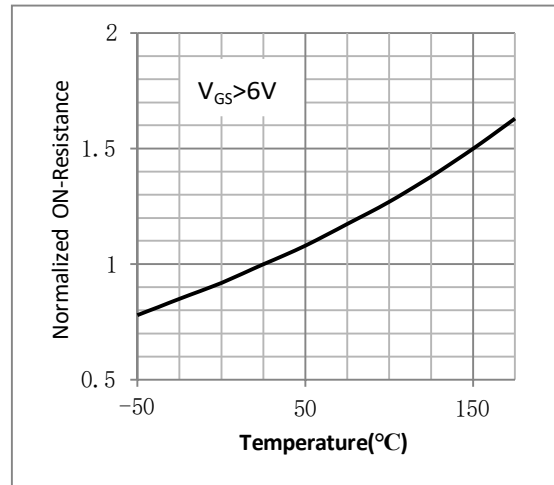


Figure 9. Diode Forward Voltage vs. Current

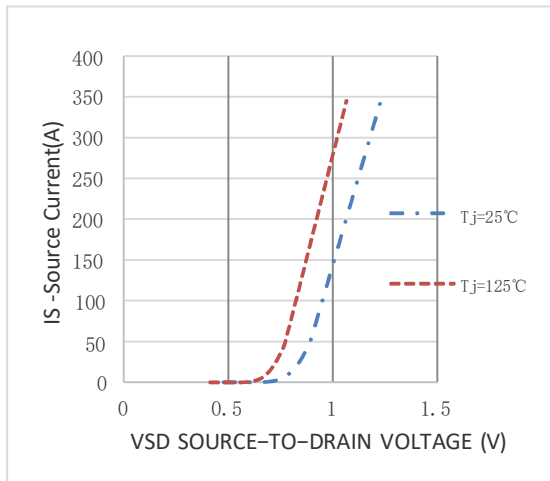


Figure 10. Transfer Characteristics

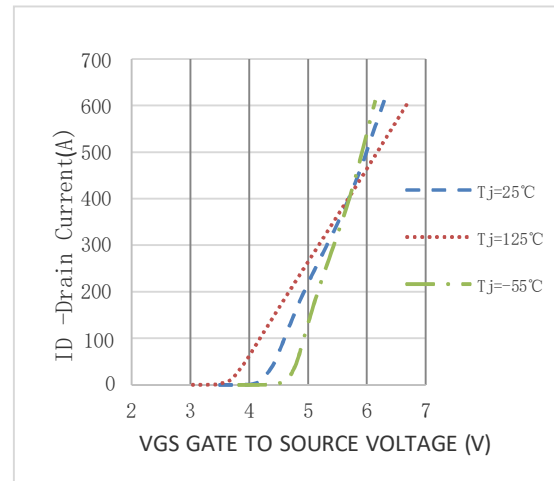


Fig.11 Safe Operating Area

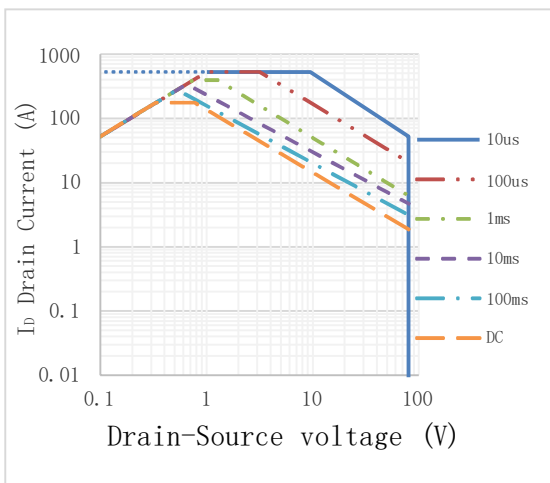
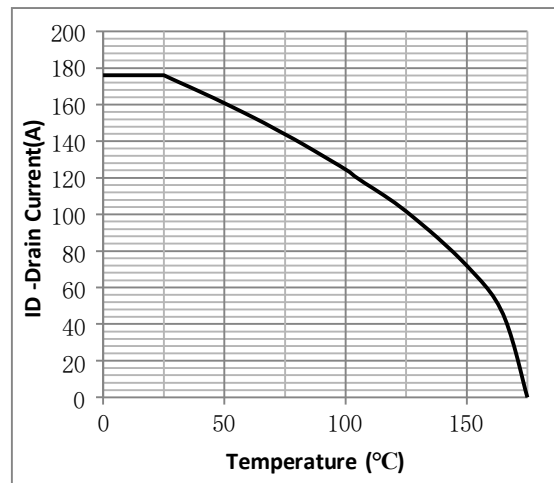
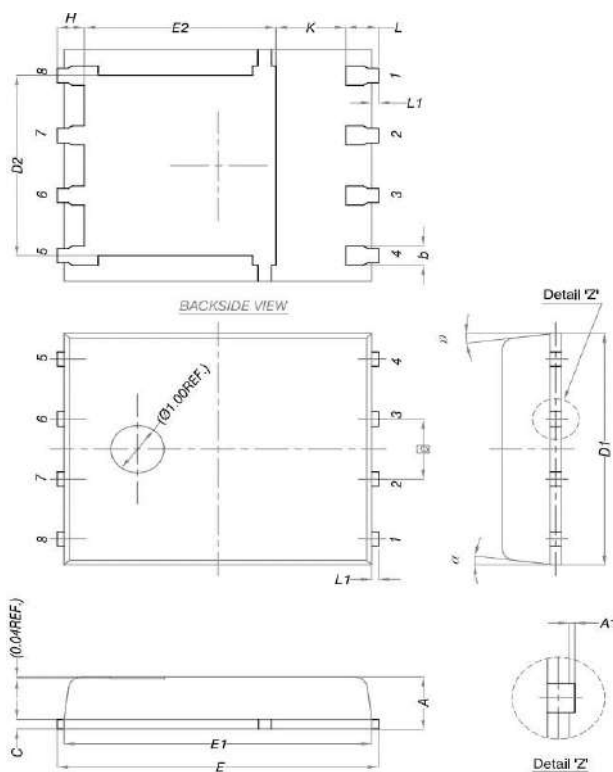


Fig.12 ID vs. Junction Temperature[®]



• DFN5*6 Package Outline



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
ϕ	1.27 BSC		
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
α	0°	-	12°